

Search Notes

Application/Control No.

09/835,821

Examiner

Mark A. Mais

Applicant(s)/Patent under
Reexamination

EIKKULA, JARI

Art Unit

2619

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|------------|----------|----------|
| 370 | 254 265 | 2/1/2008 | MAM |
| | 270 433 | | |
| | 443 455 | | |
| | 463 | | |
| 709 | 212 217 | | |
| | 223 | | |
| 379 | 111 | | |
| | 112.01 | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |

INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|------|----------|
| | | | |
| | | | |
| | | | |
| | | | |

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|---|-----------|------|
| Wellington Chin | 9/20/2005 | MAM |
| See Attached Electronic Search | 9/20/2005 | MAM |
| See Inventorship Search | 9/20/2005 | MAM |
| See Non-Patent Literature Search | 6/1/2006 | MAM |
| See Attached Electronic Search [updated] | 6/26/2006 | MAM |
| See Attached Electronic Search [updated] | 2/18/2007 | MAM |
| See Attached Electronic Search [updated] | 8/9/2007 | MAM |
| See Attached Electronic Search [updated] | 2/1/2008 | MAM |